

**AMENDMENTS TO THE SPECIFICATION**

Please amend the specification on page 23, line 15 through line 27 as follows:

**(4) Maximum light ray reflectivity**

A 60-diameter integrating sphere 130-0632 (Hitachi Ltd.) and a 10°-inclined spacer were attached to a spectrophotometer (U-3410, ~~Spectrophotometer~~ Spectrophotometer) manufactured by Hitachi Ltd., so as to measure the reflectivity using unpolarized light. The sample was set to make the longitudinal direction thereof consistent with the up-and-down direction. Its band parameter was set to 2/servo, and its gain was set to 3. In the range of 400 to 2500 nm, the reflectivity was measured at a detecting rate of 120 nm/min. In order to normalize the reflectivity, accessory Al<sub>2</sub>O<sub>3</sub> was used as a standard reflecting plate. The highest reflectivity in the wavelength range of 400 to 2500 nm was decided as the maximum light ray reflectivity.